Search Notes

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
10/815,720.	CHANG, JEN-CHIH		
Examiner	Art Unit		
Thomas M. Lithgow	1724		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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